Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,460	CHIBA, MITSURU	
Examiner	Art Unit	
Scott Bushey	1724	

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	Previous	8/7/2006	СЅВ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated Previous	8/7/2006	CSB		